

Application/Control No.	Applicant(s)/Patent under Reexamination LIOW ET AL.	
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Examiner	Art Unit	
Jorge L. Ortiz-Criado	2627	

ass Dat	
	te Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
update search	7/19/2007	JOC	
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